



One Megabit per Second Triple Digital Isolators

### FEATURES

- 1-Mbps Signaling Rate
  - Low Channel-to-Channel Output Skew;
     1 ns Maximum
  - Low Pulse-Width Distortion (PWD);
     2 ns Maximum
  - Low Jitter Content; 1 ns Typ at 150 Mbps
- Typical 25-Year Life at Rated Working Voltage (See Application note SLLA197 and Figure 10)
- 4000-V<sub>peak</sub> Isolation, 560-V<sub>peak</sub> V<sub>IORM</sub>
  - UL 1577, IEC 60747-5-2 (VDE 0884, Rev 2), IE 61010-1 and CSA Approved
- 4 kV ESD Protection
- Operate With 3.3-V or 5-V Supplies

- High Electromagnetic Immunity
   (See Application note SLLA181)
- -40°C to 125°C Operating Range

# APPLICATIONS

- Industrial Fieldbus
- Computer Peripheral Interface
- Servo Control Interface
- Data Acquisition

# DESCRIPTION

See the Product Notification section. The ISO7230A and ISO7231A are triple-channel digital isolators each with multiple channel configurations and output enable functions. These devices have logic input and output buffers separated by TI's silicon dioxide (SiO<sub>2</sub>) isolation barrier. Used in conjunction with isolated power supplies, these devices block high voltage, isolate grounds, and prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry.

The ISO7230 triple-channel device has all three channels in the same direction while the ISO7231 has two channels in one direction and one channel in opposition. These devices have an active-high output enable that when driven to a low level, places the output in a high-impedance state.

The ISO7230A and ISO7231A have TTL input thresholds and a noise-filter at the input that prevents transient pulses of up to 2 ns in duration from being passed to the output of the device.

In each device a periodic update pulse is sent across the isolation barrier to ensure the proper dc level of the output. If this dc-refresh pulse is not received, the input is assumed to be unpowered or not being actively driven, and the failsafe circuit drives the output to a logic high state. (Contact TI for a logic low failsafe option).

These devices require two supply voltages of 3.3-V, 5-V, or any combination. All inputs are 5-V tolerant when supplied from a 3.3-V supply and all outputs are 4-mA CMOS. These devices are characterized for operation over the ambient temperature range of -40°C to 125°C.

ISO7230 DW PACKAGE		ISO7231 DW PACKAGE
IN <sub>A</sub> □ 3 14 □ 0 IN <sub>B</sub> □ 4 13 □ 0 IN <sub>C</sub> □ 5 12 □ 0 NC □ 6 11 □ N	$ \begin{array}{cccc} GND2 & GND1 \square \square \\ DUT_{A} & IN_{A} \square \\ DUT_{B} & IN_{B} \square \\ DUT_{C} & OUT_{C} \square \end{array} $	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$
GND1 <del>□ 8 <sup>   </sup> 9</del> □ G	GND2 GND1 🖂	<u>8 <sup>¦ ¦</sup> 9</u> ⊐⊐ GND2



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## FUNCTION DIAGRAM

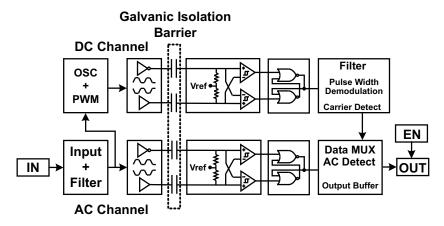


Table 1. Device Function Table ISO723x <sup>(1)</sup>

INPUT V <sub>CC</sub>	OUTPUT V <sub>CC</sub>	INPUT (IN)	OUTPUT ENABLE (EN)	OUTPUT (OUT)
		Н	H or Open	Н
PU	ווס	PU L H or Ope		L
PU	PU	Х	L	Z
		Open	H or Open	Н
PD	PU	Х	H or Open	Н
PD	PU	Х	L	Z

(1) PU = Powered Up; PD = Powered Down ; X = Irrelevant; H = High Level; L = Low Level

### AVAILABLE OPTIONS

PRODUCT	SIGNALING RATE	INPUT THRESHOLD	CHANNEL CONFIGURATION	MARKED AS	ORDERING NUMBER <sup>(1)</sup>
ISO7230ADW	1 Mbps	~1.5 V (TTL) (CMOS compatible)	3/0	ISO7230A	ISO7230ADW (rail) ISO7230ADWR (reel)
ISO7231ADW	1 Mbps	~1.5 V (TTL) (CMOS compatible)	2/1	ISO7231A	ISO7231ADW (rail) ISO7231ADWR (reel)

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

					VALUE	UNIT
$V_{CC}$	Supply voltage	ge <sup>(2)</sup> , V <sub>CC1</sub> , V <sub>CC2</sub>			–0.5 to 6	V
VI	Voltage at IN	, OUT, EN			–0.5 to 6	V
I <sub>O</sub>	Output currer	nt			±15	mA
		Human Body Model	JEDEC Standard 22, Test Method A114-C.01		±4	
ESD	Electrostatic discharge	Field-Induced-Charged Device Model	JEDEC Standard 22, Test Method C101	All pins	±1	kV
		Machine Model	ANSI/ESDS5.2-1996		±200	V
TJ	Maximum jur	ction temperature			170	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to network ground terminal and are peak voltage values.

# **RECOMMENDED OPERATING CONDITIONS**

		MIN	TYP	MAX	UNIT
$V_{CC}$	Supply voltage <sup>(1)</sup> , V <sub>CC1</sub> , V <sub>CC2</sub>	3.15		5.5	V
I <sub>OH</sub>	High-level output current			4	mA
I <sub>OL</sub>	Low-level output current	-4			mA
t <sub>ui</sub>	Input pulse width	1			μs
1/t <sub>ui</sub>	Signaling rate	0	1500 <sup>(2)</sup>	1000	kbps
VIH	High-level input voltage (IN) (EN on all devices)	2		$V_{CC}$	V
VIL	Low-level input voltage (IN) (EN on all devices)	0		0.8	v
ΤJ	Junction temperature			150	°C
н	External magnetic field-strength immunity per IEC 61000-4-8 and IEC 61000-4-9 certification			1000	A/m

(1) For the 5-V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5 V to 5.5 V. For the 3-V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15 V to 3.6 V.

Typical signaling rate under ideal conditions at 25°C. (2)



# ELECTRICAL CHARACTERISTICS: $V_{CC1}$ and $V_{CC2}$ at 5-V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT		-	I		I	
	10070004	Quiescent	$V_{I} = V_{CC}$ or 0 V, All channels, no load,		1	3	0
	ISO7230A	1 Mbps	EN <sub>2</sub> at 3 V		1	3	mA
I <sub>CC1</sub>	ISO7231A	Quiescent	$V_{I} = V_{CC}$ or 0 V, All channels, no load,		6.5	11	~ ^
	150723TA	1 Mbps	$EN_1$ at 3 V, $EN_2$ at 3 V		6.5	11	mA
-	1607000	Quiescent	$V_{I} = V_{CC}$ or 0 V, All channels, no load,		15	22	~ ^
	ISO7230A	1 Mbps	EN <sub>2</sub> at 3 V		16	22	mA
I <sub>CC2</sub>	ISO7231A	Quiescent	$V_{I} = V_{CC}$ or 0 V, All channels, no load,		13	20	~ ^
	150723TA	1 Mbps	$EN_1$ at 3 V, $EN_2$ at 3 V		13	20	mA
ELECTR	ICAL CHARACTERISTIC	S					
I <sub>OFF</sub>	Sleep mode output curre	ent	EN at 0 V, Single channel		0		μA
V	High-level output voltage	2	I <sub>OH</sub> = -4 mA, See Figure 1	$V_{CC} - 0.8$			V
V <sub>OH</sub>	Figh-level output voltage	8	$I_{OH} = -20 \ \mu A$ , See Figure 1	$V_{CC} - 0.1$			v
V	Low-level output voltage		I <sub>OL</sub> = 4 mA, See Figure 1			0.4	V
V <sub>OL</sub>	Low-level output voltage	;	$I_{OL} = 20 \ \mu A$ , See Figure 1			0.1	v
V <sub>I(HYS)</sub>	Input voltage hysteresis				150		mV
I <sub>IH</sub>	High-level input current		IN from 0.1/ to 1/			10	
I <sub>IL</sub>	Low-level input current		IN from 0 V to V <sub>CC</sub>	-10			μA
CI	Input capacitance to gro	ound	IN at $V_{CC}$ , $V_I = 0.4 \sin (4E6\pi t)$		2		pF
CMTI	Common-mode transien	t immunity	$V_{I} = V_{CC}$ or 0 V, See Figure 4	25	50		kV/μs

# SWITCHING CHARACTERISTICS: $V_{\text{CC1}}$ and $V_{\text{CC2}}$ at 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	Sac Figure 1	40		95	20
PWD	Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub>	See Figure 1			10	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew (2)			0	2	ns
t <sub>r</sub>	Output signal rise time	See Figure 1		2		20
t <sub>f</sub>	Output signal fall time			2		ns
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-impedance output			15	20	
t <sub>PZH</sub>	Propagation delay, high-impedance-to-high-level output			15	20	
t <sub>PLZ</sub>	Propagation delay, low-level-to-high-impedance output	See Figure 2		15	20	ns
t <sub>PZL</sub>	Propagation delay, high-impedance-to-low-level output			15	20	
t <sub>fs</sub>	Failsafe output delay time from input power loss	See Figure 3		12		μs

(1) Also referred to as pulse skew.

(2)  $t_{sk(0)}$  is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.



# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> at 5-V, V<sub>CC2</sub> at 3.3-V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

1 1 6.5	3	mA
1 6.5		mA
6.5	3	mA
0.5	11	
6.5	11	mA
9	15	~ ^
9.5	15	mA
8	12	mA
8	12	IIIA
0		μΑ
		V
	0.4	V
	0.1	v
150		mV
	10	^
		μA
2		pF
		kV/μs
	2	0.1 150 10

(1) For the 5-V operation, V<sub>CC1</sub> or V<sub>CC2</sub> is specified from 4.5 V to 5.5 V. For the 3-V operation, V<sub>CC1</sub> or V<sub>CC2</sub> is specified from 3.15 V to 3.6 V.

# SWITCHING CHARACTERISTICS: $V_{CC1}$ at 5-V, $V_{CC2}$ at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay, low-to-high-level output	ISO723xA	See Figure 1	40		100	
PWD	Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> – t <sub>PLH</sub>	- 150723XA	See Figure 1			11	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew <sup>(2)</sup>	ISO723xA			0	2.5	ns
t <sub>r</sub>	Output signal rise time		See Figure 1		2		~~
t <sub>f</sub>	Output signal fall time		See Figure 1		2		ns
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-impeda	ince output			15	20	
t <sub>PZH</sub>	Propagation delay, high-impedance-to-high-le	evel output	See Figure 2		15	20	
t <sub>PLZ</sub>	Propagation delay, low-level-to-high-impedance output		See Figure 2		15	20	ns
t <sub>PZL</sub>	Propagation delay, high-impedance-to-low-level output				15	20	
t <sub>fs</sub>	Failsafe output delay time from input power l	oss	See Figure 3		18		μs

(1) Also known as pulse skew

(2)  $t_{sk(o)}$  is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

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# ELECTRICAL CHARACTERISTICS: $V_{CC1}$ at 3.3-V, $V_{CC2}$ at 5-V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMET	ER	TEST CONDITION	S	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT						I	
	10070004	Quiescent				0.5	1	4
	ISO7230A	1 Mbps	$v_{\rm I} = v_{\rm CC}$ or 0 v, All channels, no lo	$V_{I} = V_{CC}$ or 0 V, All channels, no load, EN <sub>2</sub> at 3 V		1	2	mA
I <sub>CC1</sub>	ISO7231A	Quiescent	$V_{I} = V_{CC}$ or 0 V, All channels, no lo	ad, EN₁ at 3 V,		4.5	7	
	1507231A	1 Mbps	EN <sub>2</sub> at 3 V	•		4.5	7	mA
	ISO7230A	Quiescent		ad EN at 21/		15	22	~ ^
	1507230A	1 Mbps	$-V_{I} = V_{CC}$ or 0 V, All channels, no los	au, En <sub>2</sub> al 3 v		16	22	mA
I <sub>CC2</sub>	ISO7231A	Quiescent	$V_{I} = V_{CC}$ or 0 V, All channels, no load, EN <sub>1</sub> at 3 V,			13	20	mA
	130723TA	1 Mbps	EN <sub>2</sub> at 3 V	EN <sub>2</sub> at 3 V		13	20	ША
ELECTR	ICAL CHARACTI	ERISTICS						
I <sub>OFF</sub>	Sleep mode ou	tput current	EN at 0 V, Single channel	EN at 0 V, Single channel		0		μΑ
				ISO7230	$V_{CC} - 0.4$			
V <sub>OH</sub>	High-level outp	ut voltage	I <sub>OH</sub> = -4 mA, See Figure 1 ISO7231 (5-V side)	V <sub>CC</sub> – 0.8			V	
			$I_{OH} = -20 \ \mu A$ , See Figure 1		V <sub>CC</sub> – 0.1			
V		ut voltogo	I <sub>OL</sub> = 4 mA, See Figure 1				0.4	V
V <sub>OL</sub>	Low-level output	u vollage	$I_{OL}$ = 20 $\mu$ A, See Figure 1	I <sub>OL</sub> = 20 μA, See Figure 1			0.1	v
V <sub>I(HYS)</sub>	Input voltage h	ysteresis				150		mV
I <sub>IH</sub>	High-level input	t current	IN from 0 1/ to 1/				10	^
IIL	Low-level input	current	IN from 0 V to V <sub>CC</sub>		-10			μA
CI	Input capacitan	ice to ground	IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$			2		pF
CMTI	Common-mode immunity	e transient	$V_{I} = V_{CC}$ or 0 V, See Figure 4		25	50		kV/μs
			1		1			

(1) For the 5-V operation, V<sub>CC1</sub> or V<sub>CC2</sub> is specified from 4.5 V to 5.5 V. For the 3-V operation, V<sub>CC1</sub> or V<sub>CC2</sub> is specified from 3.15 V to 3.6 V.

# SWITCHING CHARACTERISTICS: V<sub>CC1</sub> at 3.3-V and V<sub>CC2</sub> at 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	ISO723xA	See Figure 1	40		100	
PWD	Pulse-width distortion <sup>(1)</sup> $ t_{PHL} - t_{PLH} $	130723XA	See Figure 1			11	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew (2)	ISO723xA			0	2.5	ns
t <sub>r</sub>	Output signal rise time				2		
t <sub>f</sub>	Output signal fall time	See Figure 1			2		ns
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-impe	edance output			15	20	
t <sub>PZH</sub>	Propagation delay, high-impedance-to-hig	h-level output			15	20	
t <sub>PLZ</sub>	Propagation delay, low-level-to-high-impedance output		- See Figure 2		15	20	ns
t <sub>PZL</sub>	Propagation delay, high-impedance-to-low	/-level output			15	20	
t <sub>fs</sub>	Failsafe output delay time from input powe	Failsafe output delay time from input power loss			12		μs

(1) Also known as pulse skew

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(2)  $t_{sk(0)}$  is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.



# ELECTRICAL CHARACTERISTICS: $V_{cc1}$ and $V_{cc2}$ at 3.3 $V^{(1)}$ OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
SUPPLY	CURRENT						
	10070004	Quiescent	$V_{I} = V_{CC}$ or 0 V, all channels, no load,		0.5	1	
	ISO7230A	1 Mbps	EN <sub>2</sub> at 3 V		1	2	mA
I <sub>CC1</sub>	10070044	Quiescent	$V_I = V_{CC}$ or 0 V, all channels, no load,		4.5	7	
	ISO7231A	1 Mbps	EN <sub>1</sub> at 3 V, EN <sub>2</sub> at 3 V		4.5	7	mA
	10070004	Quiescent	$V_{I} = V_{CC}$ or 0 V, all channels, no load,		9	15	
	ISO7230A	1 Mbps	EN <sub>2</sub> at 3 V		9.5	15	mA
I <sub>CC2</sub>	10070044	Quiescent	$V_{I} = V_{CC}$ or 0 V, all channels, no load,		8	12	
	ISO7231A	1 Mbps	EN <sub>1</sub> at 3 V, EN <sub>2</sub> at 3 V		8	12	mA
ELECTR	ICAL CHARACTERISTICS						
I <sub>OFF</sub>	Sleep mode output current		EN at 0 V, single channel		0		μA
V	High-level output voltage		I <sub>OH</sub> = -4 mA, See Figure 1	$V_{CC} - 0.4$			V
V <sub>OH</sub>	High-level output voltage		$I_{OH} = -20 \ \mu A$ , See Figure 1	V <sub>CC</sub> – 0.1			v
V	Low-level output voltage		I <sub>OL</sub> = 4 mA, See Figure 1			0.4	V
V <sub>OL</sub>	Low-level output voltage		$I_{OL}$ = 20 $\mu$ A, See Figure 1			0.1	v
V <sub>I(HYS)</sub>	Input voltage hysteresis				150		mV
I <sub>IH</sub>	High-level input current Low-level input current		IN from 0 \/ or \/			10	۵
IIL			IN from 0 V or V <sub>CC</sub>	-10			μA
CI	Input capacitance to ground		IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$		2		pF
CMTI	Common-mode transient imm	nunity	$V_1 = V_{CC}$ or 0 V, See Figure 4	25	50		kV/μs

(1) For the 5-V operation, V<sub>CC1</sub> or V<sub>CC2</sub> is specified from 4.5 V to 5.5 V. For the 3-V operation, V<sub>CC1</sub> or V<sub>CC2</sub> is specified from 3.15 V to 3.6 V.

# SWITCHING CHARACTERISTICS: $V_{CC1}$ and $V_{CC2}$ at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

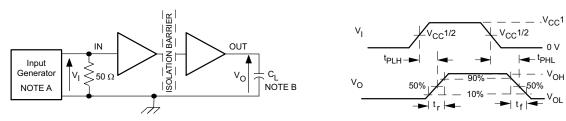
	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	100700-4	See Figure 1	45		110	
PWD	Pulse-width distortion <sup>(1)</sup> $ t_{PHL} - t_{PLH} $	ISO723xA	See Figure 1			12	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew (2)	ISO723xA			0	3	ns
t <sub>r</sub>	Output signal rise time		- See Figure 1		2		
t <sub>f</sub>	Output signal fall time	Output signal fall time			2		ns
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-impedance output Propagation delay, high-impedance-to-high-level output				15	20	_
t <sub>PZH</sub>					15	20	
t <sub>PLZ</sub> Propagation delay, low-level-to-high-impedance output		See Figure 2		15	20	ns	
t <sub>PZL</sub>	Propagation delay, high-impedance-to-lo			15	20		
t <sub>fs</sub>	Failsafe output delay time from input po	See Figure 3		18		μs	

(1) Also referred to as pulse skew.

(2)  $t_{sk(0)}$  is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

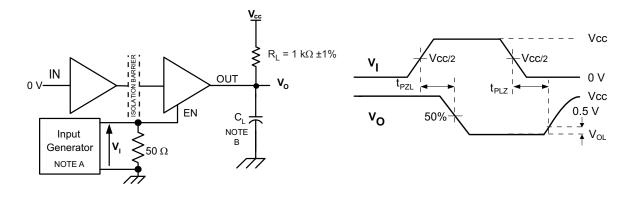


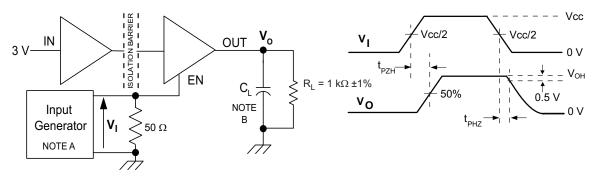
### PARAMETER MEASUREMENT INFORMATION



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50 kHz, 50% duty cycle, t<sub>r</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns, Z<sub>0</sub> = 50 $\Omega$ .
- B.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within ±20%.

### Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



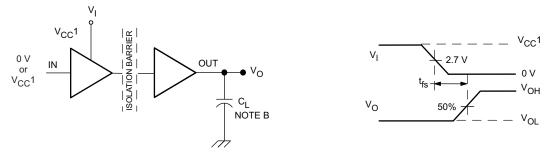


- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50 kHz, 50% duty cycle, t<sub>r</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns, Z<sub>0</sub> = 50 $\Omega$ .
- B.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within ±20%.

Figure 2. Enable/Disable Propagation Delay Time Test Circuit and Waveform

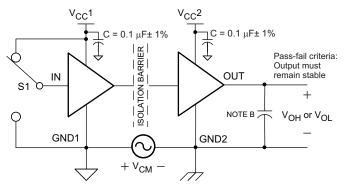


### PARAMETER MEASUREMENT INFORMATION (continued)



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50 kHz, 50% duty cycle, t<sub>r</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns, Z<sub>O</sub> = 50 $\Omega$ .
- B.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within ±20%.

#### Figure 3. Failsafe Delay Time Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50 kHz, 50% duty cycle, t<sub>r</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns, Z<sub>O</sub> = 50 $\Omega$ .
- B.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within ±20%.

Figure 4. Common-Mode Transient Immunity Test Circuit and Voltage Waveform

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# **DEVICE INFORMATION**

# PACKAGE CHARACTERISTICS

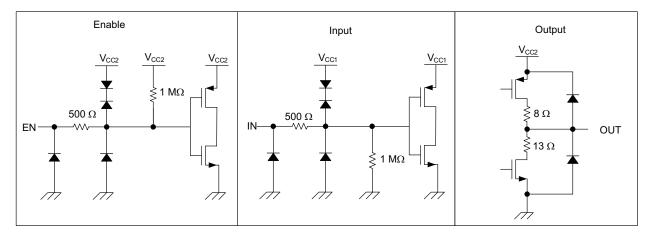
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
L(I01)	Minimum air gap (Clearance)	Shortest terminal-to-terminal distance through air	8.34			mm
L(I02)	Minimum external tracking (Creepage)	Shortest terminal-to-terminal distance across the package surface	8.1			mm
	Minimum Internal Gap (Internal Clearance)	Distance through the insulation	0.008			mm
R <sub>IO</sub>	Isolation resistance	Input to output, $V_{IO}$ = 500 V, all pins on each side of the barrier tied together creating a two-terminal device, $T_A < 100^{\circ}C$		>10 <sup>12</sup>		Ω
		Input to output, $V_{IO} = 500 \text{ V}$ , $100^{\circ}\text{C} \le \text{T}_{A} \le \text{T}_{A} \text{ max}$		>10 <sup>11</sup>		Ω
CIO	Barrier capacitance Input to output	V <sub>I</sub> = 0.4 sin (4E6πt)		2		pF
CI	Input capacitance to ground	V <sub>I</sub> = 0.4 sin (4E6πt)		2		pF

### **REGULATORY INFORMATION**

VDE	CSA	UL
Certified according to IEC 60747-5-2	Approved under CSA Component Acceptance Notice	Recognized under 1577 Component Recognition Program <sup>(1)</sup>
File Number: 40016131	File Number: 1698195	File Number: E181974

(1) Production tested  $\geq$  3000 VRMS for 1 second in accordance with UL 1577.

## **DEVICE I/O SCHEMATICS**



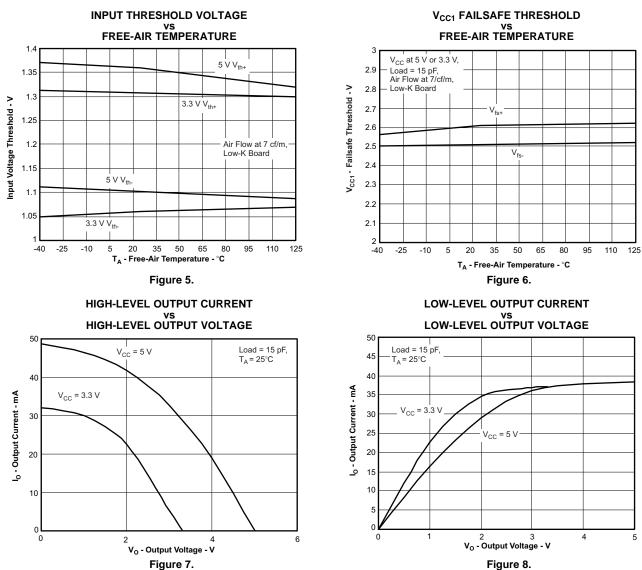


### THERMAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
0	Junction-to-air	Low-K Thermal Resistance <sup>(1)</sup>		168		°C/W
$\theta_{JA}$	Junction-to-an	High-K Thermal Resistance		96.1		C/W
$\theta_{JB}$	Junction-to-Board Thermal Resistance			61		°C/W
$\theta_{\text{JC}}$	Junction-to-Case Thermal Resistance			48		°C/W
$P_D$	Device Power Dissipation	$V_{CC1} = V_{CC2} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C}, C_L = 15 \text{ pF},$ Input a 50% duty cycle square wave			220	mW

(1) Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leaded surface mount packages.



# **TYPICAL CHARACTERISTIC CURVES**

Figure 8.

TEXAS INSTRUMENTS

www.ti.com

### **APPLICATION INFORMATION**

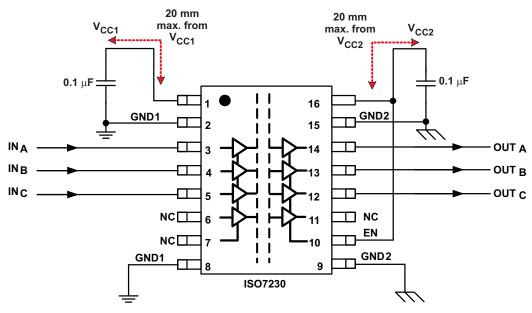


Figure 9. Typical ISO7230 Application Circuit

# LIFE EXPECTANCY vs WORKING VOLTAGE

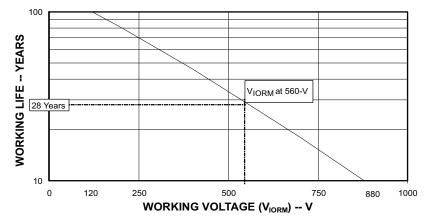


Figure 10. Time Dependant Dielectric Breakdown Testing Results



### PRODUCT NOTIFICATION

An ISO723xA anomaly occurs when a negative-going pulse below the specified 1  $\mu$ s minimum bit width is input to the device. The output locks in a logic-low condition until the next rising edge occurs after a 1  $\mu$ s period.

Positive noise edges in pulses of less than the minimum specified 1  $\mu$ s have no effect on the device, and are properly filtered.

To prevent noise from interfering with ISO723xA performance, it is recommended that an appropriately sized capacitor be placed on each input of the device

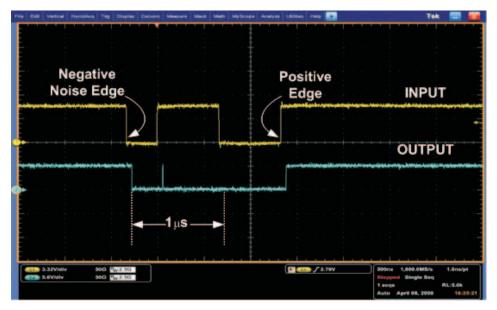


Figure 11. ISO723xA Anomaly

### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
ISO7230ADW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
ISO7230ADWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
ISO7230ADWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
ISO7230ADWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
ISO7231ADW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
ISO7231ADWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
ISO7231ADWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
ISO7231ADWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

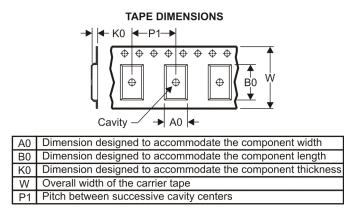
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# TAPE AND REEL INFORMATION





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

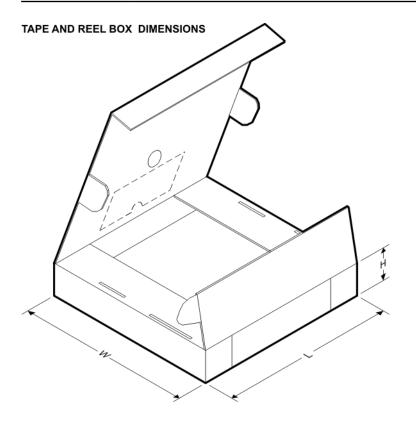


*All dimensions are nominal												
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7230ADWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7231ADWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1



# PACKAGE MATERIALS INFORMATION

20-Nov-2008



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7230ADWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7231ADWR	SOIC	DW	16	2000	358.0	335.0	35.0

DW (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AA.



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